

<b>Notice of References Cited</b>	Application/Control No. 10/727,220		Applicant(s)/Patent Under Reexamination SCHULTZ ET AL.	
	Examiner Andy Huynh		Art Unit 2818	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2003/0052594	03-2003	Matsui et al.	313/495
	C	US-2003/0189829	10-2003	Shimizu et al.	362/240
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	K	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

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